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SN74LVCZ244A

SCES274I-MAY 1999-REVISED OCTOBER 2014

SN74LVCZ244A Octal Buffer/Driver With 3-State Outputs

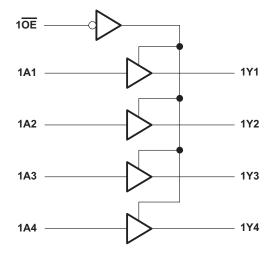
1 Features

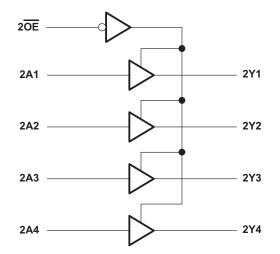
- Operates From 2.7 V to 3.6 V
- Inputs Accept Voltages to 5.5 V
- Max t_{pd} of 5.9 ns at 3.3 V
- Typical V_{OLP} (Output Ground Bounce) < 0.8 V at V_{CC} = 3.3 V, T_A = 25°C
- Typical V_{OHV} (Output V_{OH} Undershoot) • > 2 V at V_{CC} = 3.3 V, T_A = 25°C
- Ioff Supports Live Insertion, Partial-Power-Down Mode, and Back-Drive Protection
- Supports Mixed-Mode Signal Operation on All Ports (5-V Input/Output Voltage With 3.3-V V_{CC})
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II

Applications 2

- Servers
- Databases
- Memory Systems
- **Network Switches**
- PCs and Notebooks

Simplified Schematic 4





3 Description

This octal buffer/line driver is designed for 2.7-V to 3.6-V V_{CC} operation.

The SN74LVCZ244A device is organized as two 4-bit line drivers with separate output-enable (OE) inputs. When \overline{OE} is low, the device passes data from the A inputs to the Y outputs. When OE is high, the outputs are in the high-impedance state.

Device Information ⁽¹⁾							
PART NUMBER	PACKAGE	BODY SIZE (NOM)					
	SSOP (20)	7.50 mm x 5.30 mm					
SN74LVCZ244A	SOP (20)	12.60 mm x 5.30 mm					
5N74LVCZ244A	TSSOP (20)	6.50 mm x 4.40 mm					
	SOIC (20)	12.80 mm x 7.50 mm					

(1) For all available packages, see the orderable addendum at the end of the data sheet.



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5 Revision History

Changes from Revision H (August 2003) to Revision I	Page
Updated document to new TI data sheet standards.	1
Deleted Ordering Information table.	1
Changed I _{off} bullet in Features.	
Added Applications.	1
Added Pin Functions table	3
Added Handling Ratings table	4
 Changed Max operating temperature to 125°C in Recommended Operating Conditions table. 	
Added Thermal Information table.	
 Added –40°C TO 125°C temperature range to Electrical Characteristics table 	5
 Added Switching Characteristics table for –40°C TO 125°C temperature range. 	
Added Typical Characteristics section	
Added Detailed Description section	
Added Application and Implementation section	
Added Power Supply Recommendations and Layout sections	

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Product Folder Links: SN74LVCZ244A



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6 Pin Configuration and Functions

DB, DW, N, NS, OR PW PACKAGE (TOP VIEW)

				1
10E [1	U	20] v _{cc}
1A1 [2		19] 20E
2Y4 [18] 1Y1
1A2 [4		17] 2A4
2Y3 [5		16] 1Y2
1A3 [6		15] 2A3
2Y2 [7		14] 1Y3
1A4 [8		13] 2A2
2Y1 [9		12] 1Y4
GND [10		11] 2A1

Pin Functions

F	PIN		DESCRIPTION
NO.	NAME	I/O	DESCRIPTION
1	1 0E	I	Output Enable 1
2	1A1	I	1A1 Input
3	2Y4	0	2Y4 Output
4	1A2	I	1A2 Input
5	2Y3	0	2Y3 Output
6	1A3	I	1A3 Input
7	2Y2	0	2Y2 Output
8	1A4	I	1A4 Input
9	2Y1	0	2Y1 Output
10	GND	—	Ground
11	2A1	I	2A1 Input
12	1Y4	0	1Y4 Output
13	2A2	I	2A2 Input
14	1Y3	0	1Y3 Output
15	2A3	I	2A3 Input
16	1Y2	0	1Y2 Output
17	2A4	I	2A4 Input
18	1Y1	0	1Y1 Output
19	2 0E	I	Output Enable 2
20	V _{CC}	—	Power Pin

TEXAS INSTRUMENTS

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7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V_{CC}	Supply voltage range		-0.5	6.5	V
VI	Input voltage range ⁽²⁾		-0.5	6.5	V
Vo	Voltage range applied to any output in the high-impedance or power-off state ⁽²⁾		-0.5	6.5	V
Vo	Voltage range applied to any output in the high or low state ⁽²⁾⁽³⁾		-0.5	V _{CC} + 0.5	V
I _{IK}	Input clamp current	V ₁ < 0		-50	mA
I _{OK}	Output clamp current	V _O < 0		-50	mA
I _O	Continuous output current			±50	mA
	Continuous current through V_{CC} or GND			±100	mA

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

(3) The value of V_{CC} is provided in the Recommended Operating Conditions table.

7.2 Handling Ratings

			MIN	MAX	UNIT
T _{stg}	Storage temperature range		-65	150	°C
V _(ESD) Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	0	2500		
	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	0	4000	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V _{CC}	Supply voltage		2.7	3.6	V
VIH	High-level input voltage	V_{CC} = 2.7 V to 3.6 V	2		V
VIL	Low-level input voltage	V_{CC} = 2.7 V to 3.6 V		0.8	V
VI	Input voltage		0	5.5	V
Vo	Output voltage	High or low state	0	V_{CC}	V
	Ouput voltage	3-state	0	5.5	V
	Ligh lovel output ourrest	$V_{CC} = 2.7 V$		-12	~
юн	High-level output current	$V_{CC} = 3 V$		-24	mA
		V _{CC} = 2.7 V		12	4
IOL	Low-level output current $V_{CC} = 3 V$			24	mA
Δt/Δv	Input transition rise or fall rate			6	ns/V
$\Delta t / \Delta V_{CC}$	Power-up ramp rate		150		µs/V
T _A	Operating free-air temperature		-40	125	°C

 All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, (SCBA004).



7.4 Thermal Information

	THERMAL METRIC ⁽¹⁾	DB	DW	NS	PW	UNIT
		20 PINS				
R_{\thetaJA}	Junction-to-ambient thermal resistance	97.7	78.7	77.9	103.5	
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	59.4	45.0	44.5	37.9	
$R_{\theta J B}$	Junction-to-board thermal resistance	52.9	46.2	45.5	54.5	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	21.4	18.3	18.3	3.3	
ψ_{JB}	Junction-to-board characterization parameter	52.5	45.8	45.1	53.9	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report (SPRA953).

7.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMET	TEST CONDITIONS		V	-40 °	C TO 85°	C	–40°C	TO 125°	C	UNIT
ER	TEST CC	JNDITIONS	V _{CC}	MIN	TYP ⁽¹⁾	MAX	MIN	TYP	MAX	UNIT
	I _{OH} = −100 μA		2.7 V to 3.6 V	$V_{CC} - 0.2$			$V_{CC} - 0.2$			
V _{OH}	I _{OH} = -12 mA		2.7 V	2.2			2.2			V
V OH			3 V	2.4			2.4			v
	I _{OH} = -24 mA		3 V	2.2			2.2			
	I _{OL} = 100 μA		2.7 V to 3.6 V			0.2			0.2	
V _{OL}	I _{OL} = 12 mA		2.7 V			0.4			0.4	V
	I _{OL} = 24 mA		3 V			0.55			0.55	
I	$V_I = 0$ to 5.5 V		3.6 V			±5			±5	μA
I _{off}	$V_{I} \text{ or } V_{O} = 5.5 \text{ V}$		0			±5			±5	μΑ
I _{OZ}	$V_0 = 0$ to 5.5 V		3.6 V			±5			±5	μA
I _{OZPU}	V_{O} = 0.5 to 2.5 V,	OE = don't care	0 to 1.5 V			±5			±5	μA
I _{OZPD}	V_{O} = 0.5 to 2.5 V,	OE = don't care	1.5 V to 0			±5			±5	μA
	$V_I = V_{CC}$ or GND					100			100	
Icc	$\begin{array}{l} 3.6 \hspace{0.1cm} V \leq V_{1} \hspace{0.1cm} \leq 5.5 \\ V^{(2)} \end{array}$	I _O = 0	3.6 V			100			100	μA
ΔI _{CC}	One input at V _{CC} – at V _{CC} or GND	0.6 V, Other inputs	2.7 V to 3.6 V			100			100	μA
Ci	$V_I = V_{CC}$ or GND		3.3 V		3.5			_		рF
Co	$V_{O} = V_{CC}$ or GND		3.3 V		5.5			_		рF

All typical values are at V_{CC} = 3.3 V, T_A = 25 ^{\circ}C. This applies in the disabled state only. (1)

(2)

7.6 Switching Characteristics, -40°C to 85°C

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

DADAMETED	FROM	то	V _{CC} = 2.7 \	1	V _{CC} = 3.3 V	± 0.3 V	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	UNIT
t _{pd}	A or B	B or A		6.9	1.5	5.9	ns
t _{en}	OE	A or B		8.6	1.5	7.6	ns
t _{dis}	OE	A or B		6.8	1.5	6.5	ns

7.7 Switching Characteristics, -40°C to 125°C

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

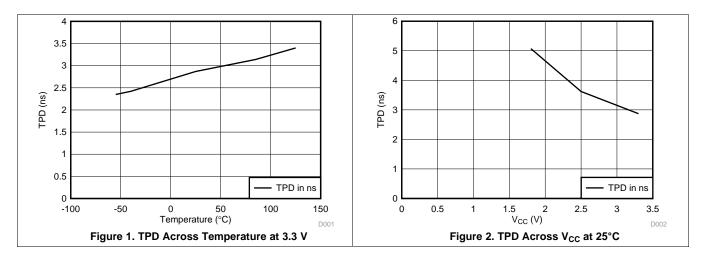
PARAMETER	FROM	то	$V_{CC} = 2$	2.7 V	V _{CC} = 3.3 V	UNIT	
	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	
t _{pd}	A or B	B or A		7.4	1.5	6.4	ns
t _{en}	OE	A or B		9.1	1.5	8.1	ns
t _{dis}	OE	A or B		7.3	1.5	7.1	ns

7.8 Operating Characteristics

 $T_A = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS	V _{CC} = 3.3 V TYP	UNIT	
0	Dower dissinction consistence per huffer/driver	Outputs enabled	f = 10 MHz	40	pF
C _{pd}	Power dissipation capacitance per buffer/driver	Outputs disabled		3	

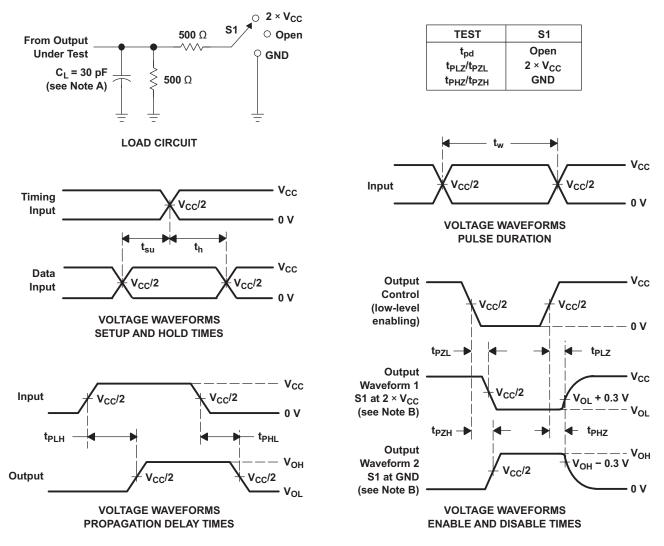
7.9 Typical Characteristics



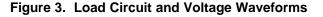


8 Parameter Measurement Information

8.1 V_{cc} = 2.7 V and 3.3 V ± 0.3 V



- NOTES: A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_r \leq 2 ns, t_f \leq 2 ns.
 - D. The outputs are measured one at a time, with one transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. t_{PZL} and t_{PZH} are the same as t_{en} .
 - G. t_{PLH} and t_{PHL} are the same as t_{pd} .
 - H. All parameters and waveforms are not applicable to all devices.



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9 Detailed Description

9.1 Overview

This octal buffer/line driver is designed for 2.7-V to 3.6-V V_{CC} operation.

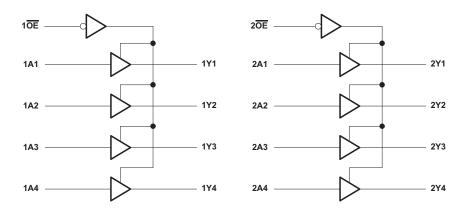
The SN74LVCZ244A device is organized as two 4-bit line drivers with separate output-enable (\overline{OE}) inputs. When \overline{OE} is low, the device passes data from the A inputs to the Y outputs. When \overline{OE} is high, the outputs are in the high-impedance state.

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of this device as a translator in a mixed 3.3-V/5-V system environment.

When V_{CC} is between 0 and 1.5 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 1.5 V, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

This device is fully specified for hot-insertion applications using I_{off} and power-up 3-state. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict.

9.2 Functional Block Diagram



9.3 Feature Description

- Wide operating voltage range
 - Operates from 2.7 V to 3.6 V
- Allows down-voltage translation
- Inputs accept voltages to 5.5 V
- I_{off} feature

8

- Allows voltages on the inputs and outputs when V_{CC} is 0 V
- Power-up 3-state feature
 - Keeps the outputs in high impedance during power up and allows for hot insertion

9.4 Device Functional Modes

INPU	JTS	OUTPUTS						
OE	Α	Y						
L	Н	Н						
L	L	L						
Н	Х	High-Z						

Table 1. Function Table



10 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

10.1 Application Information

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of this device as a translator in a mixed 3.3-V/5-V system environment.

The SN74LVCZ244A device is fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down. This device is fully specified for hot-insertion applications using I_{off} and power-up 3-state. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict. To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

10.2 Typical Application

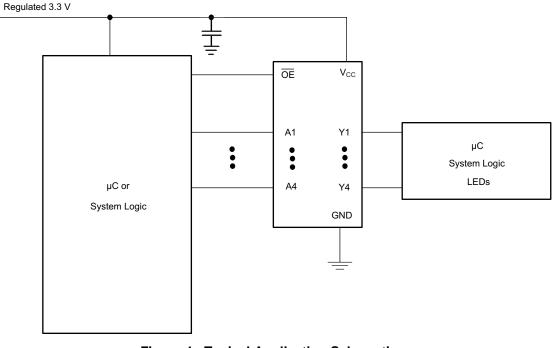


Figure 4. Typical Application Schematic

10.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Care should be taken to avoid bus contention, because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads; therefore, routing and load conditions should be considered to prevent ringing.

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SN74LVCZ244A

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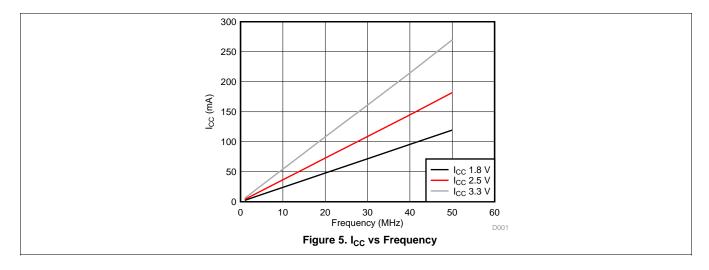
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Typical Application (continued)

10.2.2 Detailed Design Procedure

- 1. Recommended Input Conditions:
 - For rise time and fall time specifications, see $\Delta t/\Delta V$ in the *Recommended Operating Conditions* table.
 - For specified high and low levels, see V_{IH} and V_{IL} in the *Recommended Operating Conditions* table.
 - Inputs are overvoltage tolerant allowing them to go as high as 5.5 V at any valid $V_{\text{CC.}}$
- 2. Recommend Output Conditions:
 - Load currents should not exceed 50 mA per output and 100 mA total for the part.
 - Outputs should not be pulled above V_{CC} .

10.2.3 Application Curves





11 Power Supply Recommendations

The power supply can be any voltage between the MIN and MAX supply voltage rating located in the *Recommended Operating Conditions* table.

Each V_{CC} pin should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, 0.1 μ F bypass capacitor is recommended. If there are multiple V_{CC} pins, 0.01 μ F or 0.022 μ F is recommended for each power pin. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. A 0.1 μ F and 1 μ F are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.

12 Layout

12.1 Layout Guidelines

When using multiple bit logic devices, inputs should not float. In many cases, functions or parts of functions of digital logic devices are unused. Some examples are when only two inputs of a triple-input AND gate are used, or when only 3 of the 4-buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states.

Specified in Figure 6 are rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or V_{CC} , whichever makes more sense or is more convenient. It is acceptable to float outputs unless the part is a transceiver. If the transceiver has an output enable pin, it will disable the outputs section of the part when asserted. This will not disable the input section of the I/Os so they also cannot float when disabled.

12.2 Layout Example

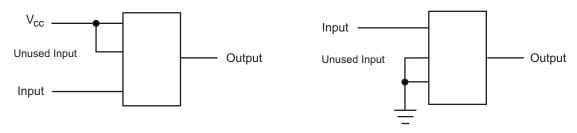


Figure 6. Layout Diagram

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13 Device and Documentation Support

13.1 Trademarks

All trademarks are the property of their respective owners.

13.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

13.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



16-Oct-2014

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing		Package Qty		Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
SN74LVCZ244ADBR	(1) ACTIVE	SSOP	DB	20	2000	(2) Green (RoHS & no Sb/Br)	(6) CU NIPDAU	(3) Level-1-260C-UNLIM	-40 to 125	(4/5) CV244A	Samples
SN74LVCZ244ADWR	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVCZ244A	Samples
SN74LVCZ244ANSR	ACTIVE	SO	NS	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVCZ244A	Samples
SN74LVCZ244APW	ACTIVE	TSSOP	PW	20	70	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CV244A	Samples
SN74LVCZ244APWR	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CV244A	Samples
SN74LVCZ244APWRG4	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CV244A	Samples
SN74LVCZ244APWT	ACTIVE	TSSOP	PW	20	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CV244A	Samples
SN74LVCZ244APWTG4	ACTIVE	TSSOP	PW	20	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	CV244A	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



16-Oct-2014

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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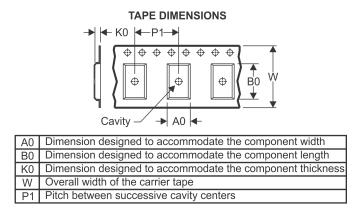
PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVCZ244ADBR	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1
SN74LVCZ244ADWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
SN74LVCZ244ANSR	SO	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1
SN74LVCZ244APWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
SN74LVCZ244APWT	TSSOP	PW	20	250	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

6-May-2017



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LVCZ244ADBR	SSOP	DB	20	2000	367.0	367.0	38.0
SN74LVCZ244ADWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74LVCZ244ANSR	SO	NS	20	2000	367.0	367.0	45.0
SN74LVCZ244APWR	TSSOP	PW	20	2000	367.0	367.0	38.0
SN74LVCZ244APWT	TSSOP	PW	20	250	367.0	367.0	38.0

MECHANICAL DATA

PLASTIC SMALL-OUTLINE PACKAGE

0,51 0,35 ⊕0,25⊛ 1,27 8 14 0,15 NOM 5,60 8,20 5,00 7,40 \bigcirc Gage Plane ₽ 0,25 7 1 1,05 0,55 0-10 Δ 0,15 0,05 Seating Plane — 2,00 MAX 0,10PINS ** 14 16 20 24 DIM 10,50 10,50 12,90 15,30 A MAX A MIN 9,90 9,90 12,30 14,70 4040062/C 03/03

NOTES: A. All linear dimensions are in millimeters.

NS (R-PDSO-G**)

14-PINS SHOWN

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



NOTES:

A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994. β . This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153



LAND PATTERN DATA



NOTES: Α. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
 C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



MECHANICAL DATA

MSSO002E - JANUARY 1995 - REVISED DECEMBER 2001

DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-150



DW0020A



PACKAGE OUTLINE

SOIC - 2.65 mm max height

SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



DW0020A

EXAMPLE BOARD LAYOUT

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



DW0020A

EXAMPLE STENCIL DESIGN

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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